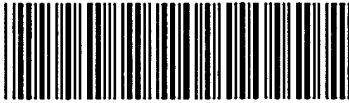


# Search Notes



Application/Control No.

10/772,420

Examiner

Mark H. Paschall

Applicant(s)/Patent under Reexamination

FLAGG ET AL.

Art Unit

3742

## SEARCHED

| Class | Subclass          | Date   | Examiner |
|-------|-------------------|--------|----------|
| 219   | 444<br>517<br>519 | 2-2-08 | m        |
|       | 507<br>509        |        |          |
|       | 510               |        |          |
|       | 511               |        |          |
|       | 509, 505          |        |          |
|       | 201, 202          |        |          |
| 166   | 54, 5             |        |          |
| 441   | 2, 33             |        |          |
|       |                   |        |          |
|       |                   |        |          |
|       |                   |        |          |
|       |                   |        |          |
|       |                   |        |          |
|       |                   |        |          |
|       |                   |        |          |

## INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

|      | DATE   | EXMR |
|------|--------|------|
| Encl | 2/2/06 | m    |
| Encl |        |      |
|      |        |      |
|      |        |      |
|      |        |      |
|      |        |      |
|      |        |      |
|      |        |      |
|      |        |      |
|      |        |      |
|      |        |      |
|      |        |      |
|      |        |      |